

<b>Notice of References Cited</b>	Application/Control No. 10/664,897	Applicant(s)/Patent Under Reexamination HAYASHI, YUKIO	
	Examiner Phuoc Tran	Art Unit 2624	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,304,607	10-2001	Talluri et al.	375/240.27
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	D	US-			
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	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

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